

Notice of References Cited

Application/Control No.

10/092,174

Applicant(s)/Patent Under
Reexamination
CONWELL ET AL.

Examiner

Phung T Nguyen

Art Unit

2632

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,884,425	03-1999	Baldwin, John	40/638
	B	US-5,477,219	12-1995	Zarembo et al.	340/572.3
	C	US-5,920,290	07-1999	McDonough et al.	343/873
	D	US-6,002,344	12-1999	Bandy et al.	340/10.2
	E	US-5,981,166	11-1999	Mandecki, Wlodek	435/4
	F	US-5,061,535	10-1991	Kreckel et al.	428/42.2
	G	US-5,629,093	05-1997	Bischof et al.	428/411.1
	H	US-4,099,838	07-1978	Cook et al.	359/537
	I	US-5,464,690	11-1995	Boswell, David R.	428/334
	J	US-5,683,774	11-1997	Faykish et al.	428/40.1
	K	US-4,746,556	05-1988	Matsuguchi et al.	428/41.1
	L	US-6,050,622	04-2000	Gustafson, Ake	292/307R
	M	US-6,255,948	07-2001	Wolpert et al.	340/572.8

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.